

**Notice of References Cited**

Application/Control No.

10/751,736

Applicant(s)/Patent Under

Reexamination

MARTINEZ ET AL.

Examiner

Lei Yao, Ph.D.

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0232350	12-2003	Afar et al.	435/6
	B	US-2001/0044130	11-2001	Glucksmann et al.	435/69.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

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